## **Supplementary Information**

## Significance of selenization with NaCl treatment on the physical properties and solar cell performance of crack-free Cu(In,Ga)Se<sub>2</sub> microcrystals absorber

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Coating conditions	CIGSe MCs powder concentration (mg)	Co Cu	ompositi In	on (at 9 Ga	%) Se	Cu/ (In+Ga)	Ga/ (In+Ga)
As-coated	100	22.81	18.18	7.40	51.61	0.89	0.29
	75	22.85	18.22	7.35	51.58	0.89	0.29
	50	22.98	17.79	7.71	51.52	0.90	0.30
An@350°C	100	22.79	18.13	7.28	51.80	0.90	0.29
	75	22.91	18.19	7.65	51.25	0.89	0.30
	50	23.15	17.96	7.80	51.09	0.90	0.30

**Table S1.** EDS composition of thin film with respect to CIGSe MCs powder concentration along with annealing temperature.

An@400°C	100	23.09	18.06	7.51	51.34	0.90	0.29
	75	23.01	18.01	7.63	51.35	0.90	0.30
	50	22.95	18.19	7.71	51.15	0.89	0.30

Table S2 The comprehensive solar cell parameters of five CIGSe MCs devices in each condition

An@350°C	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA/cm <sup>2</sup> )	FF (%)	PCE (%)
Solar Cell 1	0.602	10.54	45.70	2.90
Solar Cell 2	0.613	12.51	42.12	3.23
Solar Cell 3	0.604	10.56	48.13	3.07
Solar Cell 4	0.627	10.33	44.00	2.85
Solar Cell 5	0.610	12.96	37.19	2.94
Average	0.611	11.38	43.43	3.00
Se@500°C	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA/cm <sup>2</sup> )	FF (%)	PCE (%)
Solar Cell 1	0.600	13.73	49.65	4.09
Solar Cell 2	0.613	13.21	49.03	3.97
Solar Cell 3	0.632	12.83	46.86	3.80
Solar Cell 4	0.615	12.92	49.33	3.92
Solar Cell 5	0.639	13.23	48.85	4.13
Average	0.620	13.18	48.74	3.98
Se@500°C with NaCl	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA/cm <sup>2</sup> )	FF (%)	PCE (%)
Solar Cell 1	0.645	16.64	46.59	5.00
Solar Cell 2	0.683	17.87	44.08	5.38
Solar Cell 3	0.669	16.49	44.42	4.90
Solar Cell 4	0.674	14.07	51.67	4.90
Solar Cell 5	0.686	16.68	50.16	5.74
Average	0.671	16.35	47.38	5.18



**Fig. S1.** (a-f) FESEM images of An@350°C, Se@500°C and Se@500°C with NaCl thin films at low and high magnifications and (g-i) corresponding thickness distribution.